# HERMES-Core—A 1.59-TOPS/mm<sup>2</sup> PCM on 14-nm CMOS In-Memory Compute Core Using 300-ps/LSB Linearized CCO-Based ADCs

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Abstract—We present a 256 × 256 in-memory compute (IMC) core designed and fabricated in 14-nm CMOS technology with backend-integrated multi-level phase change memory (PCM). It comprises 256 linearized current-controlled oscillator (CCO)-based A/D converters (ADCs) at a compact 4- $\mu$ m pitch and a local digital processing unit (LDPU) performing affine scaling and ReLU operations. A frequency-linearization technique for CCO is introduced, which increases the maximum

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CCO frequency beyond 3 GHz, while ensuring accurate onchip matrix-vector multiplications (MVMs). Moreover, the design and functionality of the digital ADC calibration procedure is described in detail and the MVM accuracy is quantified. Finally, the measured classification accuracies of deep learning (DL) inference applications on the MNIST and CIFAR-10 datasets, when two IMC cores are employed, are presented. For a performance density of 1.59 TOPS/mm<sup>2</sup>, a measured energy efficiency of 10.5 TOPS/W, at a main clock frequency of 1 GHz, is achieved.

*Index Terms*—Analog computing, deep learning, in-memory computing, phase-change memory.

#### I. INTRODUCTION

N-MEMORY computing (IMC) is an emerging non-von Neumann paradigm where computation is performed in the memory array itself [1], [2]. Basically, the conventional memory systems are endowed with in-place computing capabilities, thus eliminating the back and forth shuttling of data between the memory and processing units, which costs energy and latency. Hence, data-centric applications that predominantly use a small set of computational operations can benefit greatly from the novel IMC paradigm. A prominent example is AI applications, and, in particular, deep-neural network inference, where matrix-vector multiplications (MVMs) dominate the workload [3].

In order to accelerate the execution of MVM operations using IMC, the memory system must be repurposed into a single instruction multiple data (SIMD) array of processing elements [4], where the input vector data is broadcasted across the matrix rows and the various partial products are summed up along a column. Standard CMOS logic-based solutions, using multi-bit multipliers and adders, can qualify for IMC operations, but only at an area and latency penalty [5], [6]. Instead, analog processing is used due to its scalability and its ability

to encode multi-bit data in a single physical quantity, such as time [7], [8], electrical current [9]–[12], charge [13]–[16], or voltage [17], [18].

The choice of the underlying memory technology for IMC ranges from conventional memory types, such as SRAM, DRAM, and Flash, to emerging memristive devices, such as metal-oxide-based resistive random access memory (ReRAM) and chalcogenide-based phase change memory (PCM). Compared to ReRAM, PCM device physics is much better understood [19]. It is expected that the volumetric switching in PCM may lead to substantially better array-level variability. PCM has also been commercialized as storage-class memory [20] and embedded memory [21]. Both PCM and ReRAM permit reliable long-term storage of multi-bit quantities in the conductance value of a single device. Subsequently, by employing Ohm's and Kirchhoff's laws, it is possible to perform MVM operations at  $\mathcal{O}(1)$  time complexity. This could lead to high throughput and highly energy-efficient systems [22], with the only disadvantage being the time- and energy-consuming programming procedures corresponding to these memristive devices.

Although experimental results on ReRAM-based IMC systems have already been demonstrated [23]–[25], complete IMC systems based on PCM crossbar arrays had been lacking till recently [26], [27]. Prior to this, most of the demonstrations have been based on either simulation studies based on the measured characteristics of individual devices or on experiments based on PCM memory chips that were re-purposed for IMC operations [28]–[30].

One of the main challenges faced during the realization of an IMC system is that the peripheral circuits, especially data converters that interface the crossbar array with the digital world, carry the largest energy overhead and could even dominate the associated latency and area footprint. In addition, voltage-based A/D converters (ADCs) are mostly used [31] that require a voltage to current conversion, usually employing a large capacitor for integration [23], [32]. This has thus far hampered the realization of large fully-parallel on-chip MVM operations at true  $\mathcal{O}(1)$  complexity. Besides MVM, neural network applications require a range of other mathematical operations to implement activation functions or to aggregate the results from layers split across crossbar arrays.

In this article, we present a more detailed description of the PCM-based HERMES core which was presented at the VLSI symposium [26]. A schematic overview of HERMES core is presented in Fig. 1. It comprises compact, low-latency, and energy-efficient current-controlled oscillator (CCO)-based ADCs, digital readout blocks, and a local digital processing unit (LDPU) performing affine scaling and ReLU operations.

The remainder of the article is organized as follows. In Section II, we present a new unit-cell design and a crossbar array of such unit cells that supports the storage of signed weights, parallel programming at  $\mathcal{O}(N)$  complexity, and the execution of signed MVM in one step. Section III discusses the proposed CCO-based ADC design that employs a linearization technique for the output frequency and that supports built-in shift-and-add operations. Furthermore, the LDPU architecture and implementation is presented. In Section IV, the

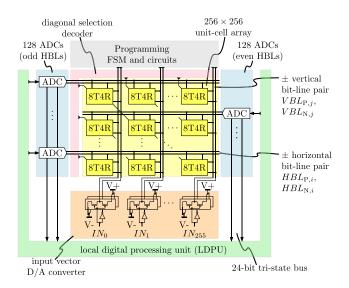


Fig. 1. System overview of the HERMES core. The memory element array (yellow) in the center consists of  $256 \times 256$  8T4R PCM unit cells. The cells are initialized via the programming circuitry (gray), located on top. During an MVM, the input vector is applied as a read voltage pulse via the input modulator (orange) on the vertical bit-lines (VBLs) of the crossbar, while the 256 ADC (blue) digitize the flowing current. The generated ADC outputs arrive via two 24-bit tri-state buses at the local digital processing unit (LDPU), where they are post-processed.

performance of the analog IMC MVM operation is analyzed for different input modulation schemes. Section V describes the inference applications on the MNIST and CIFAR-10 datasets, hardware-aware training and the experimental results thereof. It also presents a comparison of the proposed PCM-based core with other state-of-the-art IMC designs. Finally, Section VI concludes the article.

# II. UNIT CELL AND ARRAY DESIGN

A single PCM core is capable of performing a fully parallel analog MVM with 256 8-bit digital inputs at  $\mathcal{O}(1)$ -complexity. Central to its architecture is an array of  $256 \times 256$  8T4R unit cells. As shown in Fig. 2(a), positive weights are represented by the combined conductance value of two mushroom-type PCM devices  $G_1^+$  and  $G_2^+$ , whereas negative weights are represented by the other two PCM devices  $G_1^-$  and  $G_2^-$ . To support the high voltages beyond 2.5 V that are required for PCM programming, a pair of stacked nMOS devices is used as a selector. The selection signals SEL<sub>1</sub> and SEL<sub>2</sub> are routed diagonally across the array, to ensure uniform current distributions across the horizontal (HBL) and vertical (VBL) bit-lines during parallel write operations [33]. The read procedure for MVMs that involves the parallel read of all the unit cells is executed as shown in Fig. 2(b). Initially, all selection signals are enabled, since the full matrix needs to be active. Also, the HBLs are pulled to the common-mode voltage  $V_{\rm cm}$ . Then, based on the input vector signs, the different VBLs are connected to either

$$V_{-} = V_{\rm cm} - V_{\rm read} \tag{1}$$

when current from the respective columns is to be added, or

$$V_{+} = V_{\rm cm} + V_{\rm read} \tag{2}$$

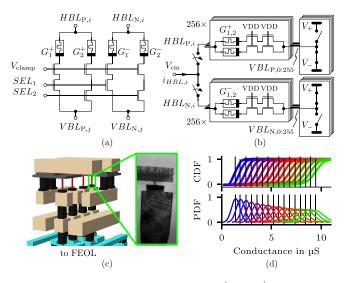


Fig. 2. (a) 8T4R unit-cell schematic. Devices  $G_1^+$  and  $G_2^+$  encode positive weight values and  $G_1^-$  and  $G_2^-$  negative values. (b) Full array read procedure during MVM for one full row. (c) PCM device insertion point in the upper part of the back-end-of-the-line (BEOL) stack. (d) Cells' storage characteristics obtained from all  $256 \times 256 \times 4$  PCM devices when encoding 16 representative levels. Note that the number of programmable levels is not limited but instead, a level-dependent standard-deviation of the programming error is encountered.

to subtract current, by applying a negative  $\Delta V$  across the PCM device. This allows all four combinations of  $\pm$ inputs and  $\pm$ weights to be taken into account in a single MVM-step without the need for negative voltages. Fig. 2(c) illustrates the insertion point of the PCM device in the upper part of the backend-of-the-line (BEOL) metal stack. Therefore, the obtained cell footprint does not yet demonstrate the full potential of the PCM on 14-nm CMOS technology, which will materialize when the insertion point is placed in immediate proximity of the transistors, as done in past technologies [34]. Representative storage characteristics of the employed mushroom PCM device are shown in Fig. 2(d) for 16 distinct levels. The analog nature of the device, however, allows the encoding of more levels, the only limit being ADC precision and allowable programming time [35], [36].

## III. LINEARIZED CCO-BASED ADC

Unlike the more commonly used voltage ADCs for IMC, time-based current ADCs eliminate the need for additional conversion cycles and are amenable to trading off precision with latency. Furthermore, since large current integration capacitors are avoided and mostly digital circuits are used, this approach facilitates having one converter per column of the crossbar, thus minimizing the overall latency as no resource sharing will be required.

## A. CCO-Based ADC Structure

Fig. 3 shows the ADC structure which has been implemented in the HERMES core. While the input D/A converter (DAC) is applying the input data to the VBLs, the generated crossbar currents arrive via the HBL wires first to Class-AB read voltage regulators, as depicted in Fig. 3(a). This type of regulator [37] can keep the HBL potentials

on common-mode  $V_{\rm cm}$  irrespective of the current polarity. By connecting to a Schmitt trigger, this polarity information is captured in the signal D.

The mirrored HBL current is then fed into the second part of the ADC, which is the CCO [see Fig. 3(b)], to generate a proportional time-encoded signal. Fig. 3(d) illustrates the waveforms of the various signals within the CCO for different amplitudes of  $i_{HBL}$  as well as different polarities. The oscillation is controlled by two small capacitors  $C_1$  and  $C_2$  that are alternately charged or discharged until either of their voltages  $V_{C1}$  or  $V_{C2}$  reaches the threshold voltage  $v_{th}$  of the connected cross-coupled inverter pair. Its flipping also toggles the latch state signal A and thus ultimately digitizes the flow of a fixed amount of charge  $Q_{\text{unit}}$  into the circuit. Based on the signal A, either the first or the second of the two symmetric slices in the oscillator operates, which ensures that always the correct side of the latch toggles. Furthermore, based on the polarity of the incoming HBL current, the signal D controls whether the integration capacitors  $C_1$  and  $C_2$  are discharged until the threshold of pMOSs  $P_1$  or  $P_2$  is reached, or are charged until the nMOSs  $N_1$  or  $N_2$  become active.

Finally, the oscillating signal A is forwarded to the last stage of the ADC, which is the dual 12-bit ripple-counter [see Fig. 3(c)], serving as an integrator for the time-encoded current information. Thus, the frequency  $f_{\rm CCO}$  of signal A is captured by the positive and negative counter outputs ADC $_P$  and ADC $_N$ , which are incremented at a rate proportional to the current  $i_{\rm HBL}$ .

# B. Linearization Technique

A known issue in this CCO circuit is the limited linearity of the output frequency  $f_{\rm CCO}$  at high input currents [38]–[40]. This is due to the constant gate delay,  $t_{\rm delay}$ , between the time instance when the latch toggles up to the time instance when the current integration proceeds on a second capacitor.  $t_{\rm delay}$  is added to the inverse of the oscillator output frequency, which is the time period  $T_{\rm CCO}$ , thus interfering with the linear relationship between frequency  $f_{\rm CCO}$  and current  $i_{\rm HBL}$ 

$$T_{\text{CCO}} = 1/f_{\text{CCO}} = \frac{C_1 \cdot v_{\text{th}}}{\alpha \cdot i_{\text{HBL}}} + t_{\text{delay}}.$$
 (3)

The solutions proposed in literature range from restriction to low-frequency operation, where the delay is not dominant [40], to extensive digital post-processing using look-up tables [41], digital filters, or other feedback structures [39]. In an IMC system, these solutions would not be ideal, as they incur either significant area or latency penalties. Moreover, the postprocessing operations aimed at compensating the nonlinearity only work for dc current measurements and would fail when working with time-varying currents that are integrated over a period of time. In this article, feed-forward compensation is proposed as a solution for the delay-induced nonlinearity issue in CCOs. The underlying idea consists of adapting the threshold voltage to compensate for the delay. This approach is different from the solution presented in [38], which modifies the reference voltage of an attached comparator circuit. Here, the trip-point  $v_{th,c}$  of the cross-coupled latch is reduced based

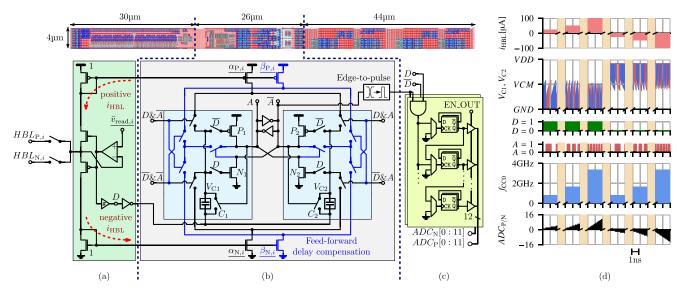


Fig. 3. Circuit diagram and layout of the CCO-based ADC that is used in the HERMES core. (a) Class-AB regulation stage that keeps the HBL on Vcm independent of the current polarity. In (b), CCO is shown. It consists of a cross-coupled latch, two pMOS and nMOS current mirrors, and two capacitive integrator stages. Control inputs per ADC for the main pMOS/nMOS current mirror gains  $(\alpha_{P/N,i})$ , the feed-forward compensation current mirror gains  $(\beta_{P/N,i})$ , and the trimmed local read voltage  $(\tilde{v}_{\text{read},i})$  are underlined. The output signal  $\bar{A}$  is fed into an edge-to-pulse converter and forwarded to the last stage, that is, (c) dual 12-bit ripple counter. (d) Waveforms during the operation of the CCO are shown for different HBL current amplitudes ( $i_{HBL} = i_{HBL,P} + i_{HBL,N}$ ).

on the instantaneous current amplitude by using a second current mirror (see Fig. 3(b) in blue)

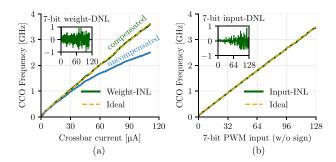
$$v_{\text{th},c}(i_{\text{HBL}}) \approx v_{\text{th}}^* - t_{\text{delay}} \cdot \frac{\alpha \cdot i_{\text{HBL}}}{C_1}.$$
 (4)

As a result, the latch flips by a predefined amount of time earlier, which can be adjusted to compensate for the delay. In this case, the current to frequency relation remains linear even for high current amplitudes

$$T_{\text{CCO}} = 1/f_{\text{CCO}} = \left(v_{\text{th}} = v_{\text{th},c}\right) \approx \frac{C_1 \cdot v_{\text{th}}^*}{\alpha \cdot i_{\text{HBI}}}.$$
 (5)

Furthermore, this feed-forward compensation technique allows counteracting other saturation effects that appear at the peak oscillator frequency by tweaking the transfer curve through active overcompensation. Such effects include, for example, the read voltage drop due to limited interconnection resistance and regulator output impedance. The drawbacks of this approach include an increased energy consumption and an initial calibration overhead, as the correct compensation gain needs to be set. Moreover, there is an increased area penalty, albeit moderate.

Each ADC measures the outputs of a multi-input-singleoutput (MISO) system, that is the result of a dot-product between a weight vector and an input vector. Therefore, the adjusted metrics of weight- and input-integral nonlinearity (INL)/differential nonlinearity (DNL) are adopted as proposed in [16]. The measured transfer curves that are shown in Fig. 4 are obtained by fixing one quantity (weight or input) while sweeping the other. Both curves remain bounded within ±1 LSB, thus indicating the absence of significant deterministic errors. Moreover, these INL/DNL plots illustrate the efficacy of the compensation technique. The linear region of the transfer curve in Fig. 4(a) is increased, and the maximum oscillation frequency can exceed 3 GHz.



Measured CCO frequency sweeps. (a) Weight-integral nonlinearity (INL) that is obtained by fixing the input value and varying the number of activated unit cells from 0 to a maximum of 256, such that full designated current range is covered. (b) Contains the input-INL measured for a sweep of the input value while all weights are active. The insets in both graphs contain the differential nonlinearity (DNL).

# C. Counter With Variable Increment Size

In the last stage of the CCO-based ADC, the oscillating signal A is integrated in the digital domain using a ripple counter. By selecting the appropriate D flip-flop that receives A, the increment size of the counter can be made variable. This allows the execution of shift-and-add operations within the ADC at a minimal overhead, avoiding dedicated multi-bit adders [42]–[44]. Hence, we enabled bit-serial input modulation in addition to the conventional multi-bit pulsewidth modulation (PWM). The negative ADC output ADC $_N$  that is read from the counter after one integration period  $T_{\rm int}$  can be formulated as

$$ADC_N = \left\lfloor \frac{1}{Q_{\text{unit}}} \int_0^{T_{\text{int}}} f(i_{\text{HBL}}(t)) dt \right\rfloor$$
 (6)

$$ADC_{N} = \left\lfloor \frac{1}{Q_{\text{unit}}} \int_{0}^{T_{\text{int}}} f(i_{\text{HBL}}(t)) dt \right\rfloor$$
(6)  
$$f(i_{\text{HBL}}(t)) = \begin{cases} |i_{\text{HBL}}(t)|, & \text{if } i_{\text{HBL}}(t) \leq 0\\ 0, & \text{otherwise.} \end{cases}$$
(7)

For the positive output ADC<sub>P</sub>, it is vice versa.

#### D. ADC Calibration Procedure

In order to ensure the best accuracy possible for applications using IMC cores, the errors introduced by gain and mismatch variations are to be kept as small as possible. Given the large number of ADCs that are involved in a large-scale IMC system, an accurate and robust calibration procedure is of high importance.

Besides inaccurate MVM results, the absence of mismatch calibration can also lead to an increased power consumption, due to currents flowing in between ADCs. This happens when the various Class-AB read-voltage regulators settle on different  $V_{\rm read}$  values. If the HBLs are on different potentials, then given the crossbar topology, current will flow between them, which manifests itself in an ADC offset and in a decreased energy efficiency. If this is added to the original CCO transfer function (3), a simplified equation for the current-to-frequency relation can be formulated that models all relevant effects

$$f_{\text{CCO}}(i_{\text{HBL}}) = \frac{A_{\text{dc}} \times i_{\text{HBL}}}{1 + B_{\text{NL}} \times i_{\text{HBL}}} + C_{\text{offset}}.$$
 (8)

Therein, the three variables  $A_{\rm dc}$ ,  $B_{\rm NL}$ , and  $C_{\rm offset}$  characterize static gain, nonlinearity, and offset for each ADC. In the employed design, they can be adjusted through three separate types of control inputs [see Fig. 3(a) and (b)]. Main current-mirror gains  $\alpha_{P,i}$ ,  $\alpha_{N,i}$  set the static gain  $A_{\rm dc}$ . The nonlinearity-related term  $B_{\rm NL}$  is reduced by increasing the feed-forward gains  $\beta_{P,i}$ ,  $\beta_{N,i}$ , and, finally, any read-voltage variation-related offset is compensated using  $\tilde{v}_{{\rm read},i}$ , which is varied by selecting a different tap from a resistor ladder.

Moreover, there is some interrelation between the different parameters. For example, the read-voltage setting  $\tilde{v}_{\text{read},i}$  impacts the static gain and the two current mirrors for static gain and feed-forward compensation also exhibit some correlation. The calibration algorithm therefore commences with fixing the offset, then proceeds to setting the static gain, and finally enables and adjusts the feed-forward compensation.

Equation (8) contains three unknown variables that change depending on the calibration settings. They are calculated by generating  $i_{HBL}$  currents of three different amplitudes and storing of the measured counter values. To accurately capture the complete transfer curve characteristics, the three current values are chosen so that they include one low and one medium current point as well as one measurement at the largest relevant current amplitude that can be realistically expected in the crossbar. In this case, a value of  $I_{HBL,max} = 100 \mu A$ was chosen. The obtained equation system is then solved to obtain the three parameters  $A_{dc}$ ,  $B_{NL}$ , and  $C_{offset}$ . By averaging over several measurements, non-systematic disturbances like thermal noise can be filtered out. Note that this process of calculating the three parameters needs to be repeated following each control input change in order to closely monitor the calibration progress. Moreover, positive and negative current mirrors must be calibrated separately.

The course of a measured calibration procedure is shown in Fig. 5. Initially, the individual read voltage values  $\tilde{v}_{\text{read},i}$  are continuously adjusted [see Fig. 5(a)] until the relative offset errors of all ADCs are reduced to almost 0% [see Fig. 5(b)].

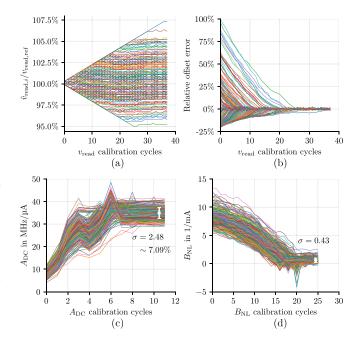


Fig. 5. Calibration procedure for the 256 CCO-based ADCs per HERMES core. (a) Evolution of the per ADC adjustable read-voltage  $\tilde{v}_{\text{read},i}$  during calibration until the relative offset errors between the ADCs are eliminated, as shown in (b). In (c), adjustment of the static ADC gain is shown and in (d), nonlinearity-related coefficient  $B_{\text{NL}}$  is minimized.

Afterward, the static gain  $A_{\rm dc}$  is set to ca. 35 (MHz/ $\mu$ A) [see Fig. 5(c)]. Despite the 4-bit gain adjustment circuitry, there is a residual spread of  $\sigma = 2.48$  (MHz/ $\mu$ A), corresponding to 7.09% of the static gain reference value. Finally, the nonlinearity-related term  $B_{\rm NL}$  that originates from switching delays and voltage drop is reduced to the lowest value possible [see Fig. 5(d)].

#### E. Local Digital Processing Unit (LDPU)

At the end of the ADC calibration process, the offset differences of the 256 ADCs are effectively eliminated, while the static gain variations are still distributed within  $\pm 21\%$  of the reference value. Equalization of the remaining difference, which in the analog domain would require significant silicon area, is performed digitally in the LDPU, which is efficiently combined with any deep learning (DL) inference-required affine scaling. This is done after the left and right blocks of 128 ADCs pass their raw 12-bit positive (ADC<sub>P</sub>) and 12-bit negative (ADC<sub>N</sub>) output data via two separate 24-bit tri-state buses to the LDPU [see Fig. 6(a)].

Therein, the  $2 \times 12$  bit data pass through the convertand-scale blocks [see Fig. 6(b)] that each contains two FP16 multiply–add units. These units apply the scaling and offset factors and also subtract positive and negative ADC values. Moreover, the LDPU supports the combination of results from layers split across multiple crossbars and can also perform residual input additions that are needed for executing ResNets. The INT8 outputs of the LDPU can be transferred to other cores.

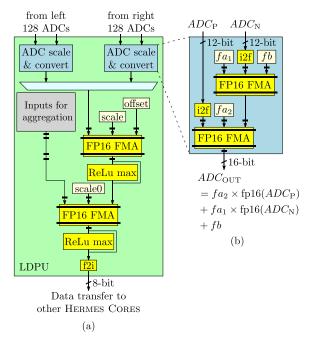


Fig. 6. (a) Block diagram of the LDPU, which receives the output data from the 256 ADCs and post-processes them in the dedicated ADC scale&convert blocks, that are shown in (b). There, remaining gain and offset variations between the different ADCs are equalized. The LDPU can furthermore apply the ReLu activation function and combine results from different HERMES cores.

#### IV. MVM OPERATION

We propose a hardware-centric approach to characterize the quality of the analog MVM operation. Using the crossbar's duality of being an MVM engine as well as a cascaded D/A and A/D system, a statistical accuracy metric can be created. First, a set of ideal fixed-point MAC results  $\vec{y}$  is defined that spans the full output range. In a second step, random FP32 weight  $(\vec{w})$  and INT8 input vectors  $(\vec{x})$  are created, as indicated in Fig. 7(a), using a uniform multinomial distribution, so that their dot-products  $\vec{w} \times \vec{x}$  yield  $\vec{y}$ . The weights  $\vec{w}$  are then programmed into the crossbar by means of iterative programming [35]. Next, the inputs  $\vec{x}$  can be applied as read-voltage pulses using either multi-bit or bitserial modulation with shift-and-add. Thus, the analog MVM is performed and the resulting HBL currents are digitized in the CCO and finally post-processed in the LDPU, yielding the hardware-obtained MVM-results  $\vec{y}_{HW}$ . These INT8 results are then compared against the FP32 reference values, as shown in Fig. 7(b) and (c). Finally, the computational accuracy can be characterized by calculating the standard deviation of the error [see Fig. 7(d) and (e)].

#### A. Multi-Bit and Bit-Serial Input Modulation

Using the HERMES core, the two supported modulation schemes are examined by comparing their respective INT8 LDPU outputs against the ideal FP32 results. The MVM results shown in Fig. 7(b) are obtained by using conventional 8-bit PWM. Following a brief VBL pre-charge procedure, the CCO-based ADCs are activated and continuously integrate the time-varying current while the modulator is active.

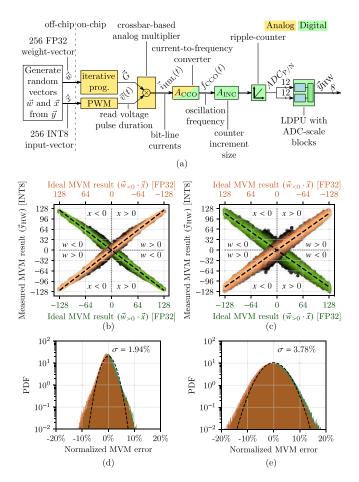


Fig. 7. (a) Experimental flow diagram that is used to determine the MVM accuracy. The measured results are shown in (b) for conventional multi-bit PWM and in (c) for bit-serial input modulation with shift-and-add. Both ±weights and inputs are used to cover all four quadrants. The probability density function (PDF) of the normalized MVM error for both modulation schemes is plotted in (d) and (e).

In the bit-serial case, however, only static currents are measured. Therein, the modulator applies the seven magnitude bits of each entry in the read-voltage vector  $\vec{x}$  from LSB to MSB to the crossbar, so that dc currents develop. After a defined settling time, these currents are measured by enabling the ADCs for a constant time period and integration of the CCO output in the attached counter. The significance of the applied input-bit is taken into account by selecting which of the first seven counter bits to increment. Thus, a shift and add operation is realized in the counter. The obtained MVM results are shown in Fig. 7(c).

In the employed conventional multi-bit modulation scheme, an integration time of 128 ns is used, given by the 1-GHz operation frequency of the modulator and the 7-bit input magnitude. Due to the peak CCO frequency of ca. 3.3 GHz, more than 420 different charge levels can be quantized and, thus, a resulting resolution of more than 8 bit is ensured. The measured MVM results in Fig. 7(b) and (d) do not show any significant systematic errors and the error distribution, if modeled as a random normal distributed Gaussian, yields a  $\sigma=1.94\%$ .

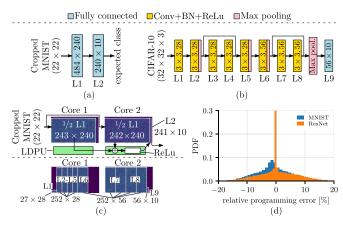


Fig. 8. Implemented network applications. (a) Two-layer MLP that is used for MNIST image classification and (b) ResNet-9 network used for CIFAR-10 image classification. (c) Layer map of MNIST and ResNet-9 networks within two HERMES cores each. (d) PDF of the relative weight programming error for the MNIST and ResNet-9 networks.

Regarding the bit-serial modulation scheme, the maximum intermediate result per input bit must be limited to 4 bit to avoid saturation or overflow in the 12-bit counters. This is achieved by limiting the integration time per input-magnitude bit to ca. 5 ns. As a consequence, only the upper 4 bit of the final result remains usable, while the remaining bits mostly consist of quantization noise. This is also reflected in the results shown in Fig. 7(c) and (e), which show a broader error histogram with twice the standard deviation than for the multibit case.

Therefore, in the remainder of this article, the conventional multi-bit modulation scheme will be used for the application studies. However, note that the encountered precision limit of bit-serial modulation is specific to the presented design and could be easily circumvented through adjustments to the counter.

# V. APPLICATIONS AND RESULTS

For experimental validation of the inference performance, a two-layer MLP [see Fig. 8(a)] and a ResNet-9 network [see Fig. 8(b)] were trained to perform MNIST or CIFAR-10 image classification, respectively. In both cases, the networks were designed so that the weights can be mapped onto the two HERMES cores, which constitute the employed demo system, as is shown in Fig. 9.

## A. Hardware-Aware Training

Prior to mapping the networks onto analog IMC cores, it is essential to perform a hardware-aware custom training in software as described in [30]. Due to device variability and noise, the networks need to be trained in a specific way so that transferring the digitally trained weights to the analog PCM devices will not result in significant loss of accuracy.

1) Two-Layer MLP: For the two-layer MLP case, the MNIST input images were cropped to  $22 \times 22$  and scaled between 0 and 1. The hidden layer of the MLP network comprises 240 neurons and employs the ReLU activation function, while the output layer comprises ten neurons and a softmax-operation step. Initially, the network was trained in

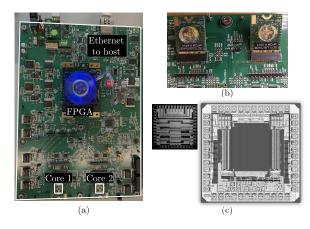


Fig. 9. (a) FPGA-based test board with two PCB-packaged HERMES cores that was used to run the neural network applications. (b) Die holder sockets and a bonded HERMES cores on holder boards with a plastic lid. (c) Chip micrograph and snapshot from the EDA tool.

floating-point arithmetic to minimize cross entropy loss with a batch size of 4 and initial learning rate of 0.0005 for 50 epochs. The weights and biases were clipped at 3.5 times the standard deviation  $\sigma_W$  of the weight distributions. The learning rate was reduced by half after every 20 epochs. Furthermore, the network was retrained while adding 15% noise to the weights for 35 epochs and clipping of the weights and biases at  $3 \times \sigma_W$  after every training batch. Following this training approach, the network achieved a 98.6% accuracy on the 10 000 cropped MNIST image test set.

2) ResNet-9: In the second application example, a ResNet-9 with 100726 trainable parameters is used for CIFAR-10 image classification, as shown in Fig. 8(b). The training images were normalized to have zero mean and unit standard deviation. In addition, the images are augmented by random cropping to  $32 \times 32$  squares after padding by four pixels on each boarder and random horizontal flipping. The network was first trained in floating-point arithmetic with a batch size of 200 and initial learning rate of 0.5 for 300 epochs of 50000 training images. The learning rate was reduced to one-tenth after every 30 epochs. As for the previous application, the network was further retrained by adding 6.67% noise to the weights for 270 epochs and clipping of the weights and biases at  $2 \times \sigma_W$  after every training batch. Eventually, the network achieved an 88.4% accuracy on the 10000 test images of CIFAR-10.

# B. Hardware Experiment

The trained weights of all layers were then mapped on two HERMES cores and iteratively programmed on the PCM unit-cell arrays. Fig. 8(c) shows the layer mapping of both networks on the two cores and Fig. 8(d) shows the resulting weight programming error. The iterative programming convergence rate was 100% for the MLP and 99.9% for ResNet-9. The relative weight programming error standard deviations of 4.8% (MLP) and 5.3% (ResNet-9) are related to the difficulty in reading accurately the individual conductance values with the on-chip ADC when iteratively programming them. This could be mitigated by increasing the ADC resolution, using

Metric	This work	ISSCC'21 [45]	ISSCC'21 [44]	ISSCC'20 [46]
CMOS technology	$14\mathrm{nm}$	$22\mathrm{nm}$	16 nm	$7\mathrm{nm}$
Memory technology	PCM	ReRAM	SRAM	SRAM
Non-volatile	Yes	Yes	No	No
Operating Voltage in V	0.8	0.8	0.8	0.8
Operation Frequency	$1\mathrm{GHz}$	-	$200\mathrm{MHz}$	-
ADC design	CCO-based ADC	Sense amplifier	8bit SAR ADC	4bit Flash-ADC
Memory size	$65.5\mathrm{K}$	$4\mathrm{M}$	$4.5\mathrm{MB}$	$4\mathrm{KB}$
Unit-cell	8T4R	1T1R	10T1C	8T
Number of input/weight/output-bits	8b/Analog/8b	8b/8b/14b	4b/4b/8b	4b/4b/4b
Peak Throughput (TOPS)	1.008	0.035	11.8   5.901	$0.372 \mid 0.186^{1}$
Energy Efficiency (TOPS/W)	10.5	11.91	$121 \mid 60.5^{1}$	$351 \mid 175.5^{1}$
Area Efficiency (TOPS/mm <sup>2</sup> )	1.59	0.013	$2.67 \mid 1.34^{1}$	$116.3 \mid 58.13^{1}$

TABLE I

COMPARISON TABLE OF RECENT ANALOG IMC-BASED MVM/MULTIPLY-ACCUMULATE (MAC)-OPERATION ACCELERATORS

drift-mitigation schemes, or increasing of the maximum number of iterations during programming.

After the weights were programmed, the inference experiment was conducted by providing as input the test images to the two-core platform. For the MNIST MLP experiment, the test images were flattened and split over cores 1 and 2 to process the first layer. The partial MVM output from core 1 was sent to the LDPU of core 2, added to the output of core 2 via the LDPU circuitry, after which the ReLU was performed on the summed output. The resulting LDPU output from the first layer was then input to core 2 for processing the second layer and to obtain the final classification result. Hence, all the inference operations for processing the MNIST test images were performed on-chip. The FPGA was used solely for control and data propagation between the cores. The resulting on-chip inference accuracy obtained on MNIST was 98.3%, which is only 0.3% lower than the software accuracy obtained after training.

For the ResNet-9 inference experiment, all the MVMs required for performing the convolutions on the CIFAR-10 images were performed on-chip. The FPGA was used to send data from one layer to the next after each layer was processed by the HERMES cores. The pooling operations, not supported by the LDPU, were performed in software. The experimentally obtained accuracy was 85.6%, which is less than 3% lower than the software accuracy. Although this accuracy difference is higher than that observed for the MNIST dataset, it is expected that the ResNet-9 on CIFAR-10, with its inherent low number of parameters, will be more sensitive to weight programming errors and also additional errors introduced by the ADC conversion. Reducing the weight programming errors and the ADC nonlinearity would be needed to bridge the accuracy gap between experiment and software. Using a larger network in addition would improve the overall robustness to these nonidealities.

## C. System-Level Performance

At an operation frequency of 1 GHz and a supply voltage of 0.8 V, the HERMES core shows a peak throughput of

1.008 TOPS at an efficiency of 10.5 TOPS/W, when running the MNIST-based experiment as described above. Compared to the state-of-the-art (shown in Table I), the measured throughput density of 1.59 TOPS/mm² is significantly higher than recent non-volatile ReRAM-based designs [24], [45] and also slightly higher than recent SRAM + capacitor-based designs [44], when 8-bit input quantization is used. Only the SRAM-based design in [46] shows a better throughput density, given by its compact 8T SRAM unit-cell design employing push-rules and the advanced manufacturing node. However, it uses a lower precision, 4 bit-based computation mode and offers no persistence throughout power cycling due to the volatile SRAM cells.

#### VI. CONCLUSION

In this article, an IMC-based MVM accelerator is presented that uses a novel PCM on 14-nm CMOS process. The compact CCO-based ADCs allow the MVM operation to be executed at  $\mathcal{O}(1)$ -complexity, since the pitches of ADC and unit-cell match. Through linearization of the ADC's current-to-frequency transfer curve, a resolution of 300 ps per LSB is demonstrated. Thus, a system performance of 1.008 TOPS at an energy efficiency of 10.5 TOPS/W is achieved.

Furthermore, the usage of a time-based ADC architecture allowed efficient implementation of shift-and-add operations within the ADC, thus obviating the need for dedicated digital adders. In addition, this enables bit-serial input modulation to be implemented natively. Both supported input modulation schemes, conventional multi-bit PWM and bit-serial modulation with shift-and-add, are compared with respect to the achievable MVM operation precision. Finally, the suitability for DNN applications is demonstrated through successful on-chip implementation of a two-layer MLP and a ResNet-9 for MNIST and CIFAR-10 image classification, respectively.

The presented system demonstrates the feasibility of a high-throughput IMC MVM accelerator system using non-volatile memristive devices. Despite the integration of the PCM element at a relatively high position in the metal stack, a throughput density of 1.59 TOPS/mm<sup>2</sup> is achieved,

<sup>&</sup>lt;sup>1</sup> normalized to 8b input

comparable to existing SRAM-based accelerators. It is conceivable that by integrating the PCM devices closer to the transistor-level at a denser pitch, substantially higher throughput density can be achieved.

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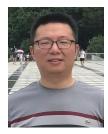
include in-memory computing and brain-inspired computing.



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